## Notice of References Cited Application/Control No. 10/583,920 Examiner SHANNON JANSSEN Applicant(s)/Patent Under Reexamination SAILOR ET AL. Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-			
	В	US-			
	U	US-			
	D	US-			
	Е	US-			
	F	US-			
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	Ι	US-			
	_	US-			
	J	US-			
	K	US-			
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## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	J	Chan et al. (Nanoscale microcavities for biomedical sensor applications, 2000, Proceedings of SPIE, Vol 3912, pp 23-34)			
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	х				

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.